

Flexible Design, Unyielding Performance

fleX-Beam[™] is a unique, compact X-ray generator that combines a low-powered X-ray source and a precisely-aligned polycapillary optic to deliver a bright X-ray beam for advanced material analysis. fleX-Beam is available in several standard focused or collimated beam configurations and can also be customized for specific applications.

Industry-Leading Performance

- fleX-Beam's intensity is up to 10,000 times greater than conventional pinhole collimators
- Focal spot as small as 5µm @ Rh Ka (20.162keV)
- 50 watt performance exceeds conventional kilowatt-powered X-ray tubes
- Integrated safety shutter & 8-position filter wheel

Simple Integration

 This comprehensive solution is compact and easily integrates with any instrument or system

Easy Serviceability & Field-Alignment

 Innovative design allows for the ability to interchange different optics, as well as service the X-ray source in the field





249mm

Custom Solutions

fleX-Beam[™] can be used in different applications where a compact X-ray source with high photon flux is required. Various configurations are available to be used in μ-XRF, diffraction, in-line process monitoring or in-situ analysis, and medical imaging applications. XOS provides custom fleX-Beam optics based on customer requirements.

Standard fleX-Beam Models

Highly-Focusing Optics						
Working distance (mm)	2	4	9	20	50	100
Focal spot size* (µm, FWHM)	8	15	25	45	100	180
Output beam intensity* (photons/s)	3.5 x 10 ⁷	7.0 x 10 ⁷	1.5 x 10 ⁸	2.0 x 10 ⁸	3.0 x 10 ⁸	4.0 x 10 ⁸

Typical Applications: Micro XRF

- Small Feature Analysis
- Film & Plating Thickness
- High-Resolution Elemental Mapping
- * Note: For Mo Ka radiation using a 100µm, Mo-anode x-ray source at 50 kV/1mA

Slightly-Focusing Optics					
Output convergent angle (degree)	0.25	0.5	1	2	
Output beam intensity	5.0 x 10 ⁸	1.6 x 10 ⁹	5.0 x 10 ⁹	1.6 x 10 ¹⁰	

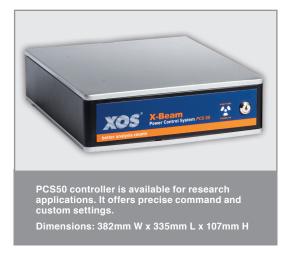
Typical Applications: XRD

- Residual Stress Analysis
- Laue Diffraction
- Powder Diffraction
- * Note: For Cu Ka radiation using a 100µm, Cu-anode x-ray source at 50 kV/1mA. Working distance is 140mm and focal spot size is 0.5mm

Highly-Collimating Optics								
Output beam diameter (mm)	0.5	1	2	3	4	6	10	20
Output beam intensity (photon/s)*	3.0 x 10 ⁸	1.2 x 10 ⁹	3.5 x 10 ⁹	6.5 x 10 ⁹	1.0 x 10 ¹⁰	1.3 x 10 ¹⁰	1.8 x 10 ¹⁰	2.5 x 10 ¹⁰

Typical Applications: XRD & WDS

- Powder Diffraction
- Texture & Strain Measurement
- Wavelength-Dispersive Spectrometer
- * Note: For Cu Ka radiation using a 100µm, Cu-anode x-ray source at 50 kV/1mA. Output beam divergent angle is 0.2°



Technical Specifications

Available Targets*	Cr, Cu, Mo, Rh, W
Nominal Output Power	50 kV / 1.0 mA / 50 W
Stability	<0.5% RSD per °C over 8 hours
Ambient Operating Temp	20°-35° C
Cooling Mode	Integrated forced air
Dimensions	101mm W x 143mm L (w/o optic) x 249mm H
Weight	5.9kg

Included: Built in safety shutter & 8-position filter wheel

*Other target materials may be available upon request.



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